| Search Notes | | | |
|--------------|--|--|--|
| | | | |

| Application/Control No. | Applicant(s)/Patent un Reexamination | nder |
|-------------------------|--------------------------------------|------|
| 09/839,055 | DEBBINS ET AL. | |
| Examiner | Art Unit | |
| Many I Stoolman | 2101 | |

| SEARCHED | | | |
|----------|--------------------------|----------|----------|
| Class | Subclass | Date | Examiner |
| 717 | 108 172 + text 178 | 12-01-05 | ms. |
| (| (himsel) | | |
| 1 | | _ | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | • | |
| | | | |
| | | | |
| | | | |
| | | | |

| INTERFERENCE SEARCHED | | | | |
|-----------------------|---------------------------------|---|--|--|
| Subclass | Date | Examiner | | |
| 108 172 178 +ta | 12-1-05 | ms | | |
| (papub) | | | | |
| | | | | |
| <u> </u> | _ | | | |
| | | | | |
| | Subclass 108 172 178 + te | Subclass Date 108 172 12:1-05 178 + try } | | |

| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | |
|---|---------|------|
| | DATE | EXMR |
| Fast V 2.0.1.4 US Pat US PG Pubs EPO IPO Derwent | | |
| IBM Feek Bul | 12.1.05 | MS |
| Non Patent Litenature Scholan. google. con IEEE ACM | 12.1.05 | m s |
| Palm Inventor Name Scarch | 12.1.65 | ms |
| Wei Zhen SPE 2191 | 11.2.05 | ms |
| | | |
| | | |
| | | |
| | | |
| | | |
| | · · · | |
| | | |
| | | |